Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/813,907	ZHANG ET AL.	
Examiner	Art Unit	
Alain L. Bashore	1762	

	SEARCHED		
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH (INCLUDING SEAR	NOTES CH STRATEGY	<b>(</b> )
	DATE	EXMR
previous search updated	7/25/2005	АВ
EAST (attached)	7/25/2005	АВ
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